Searcn Notes				
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/655,221	LEE ET AL.	
Examiner	Art Unit	
Mike Qi	2871	

SEARCHED				
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Class	Subclass	Date	Examiner	
349	129,106 130,106 123	2/15/2006	ZQQ	
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INTERFERENCE SEARCHED				
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SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
East search; US-PGPUB;USPAT;USOCR; EPO;JPO;DERWENT;IBM_TDB; update search; (see search history printout)	2/15/2006	ZQQ